TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

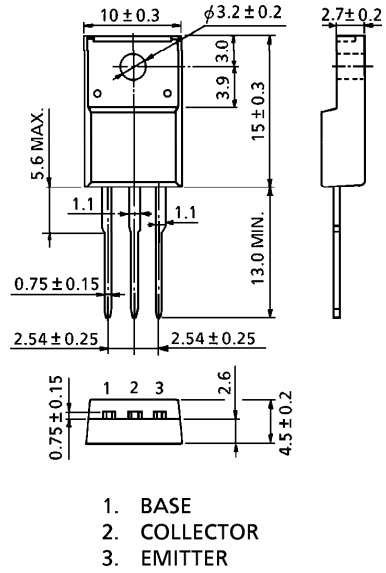
2SD1410A

IGNITER APPLICATIONS

HIGH VOLTAGE SWITCHING APPLICATIONS

- High DC Current Gain : h_{FE} = 2000 (Min.)
  (V_{CE} = 2 V, I_C = 2 A)

Unit in mm



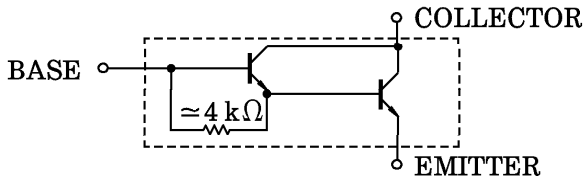
JEDEC	—
JEITA	—
TOSHIBA	2-10R1A

Weight : 1.7 g (Typ.)

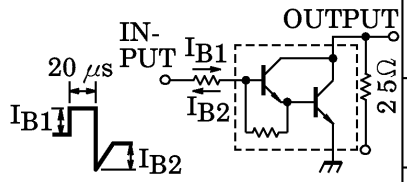
MAXIMUM RATINGS (Tc = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Collector-Base Voltage		V_{CBO}	300	V
Collector-Emitter Voltage		V_{CEO}	250	V
Emitter-Base Voltage		V_{EBO}	5	V
Collector Current		I_C	6	A
Base Current		I_B	1	A
Collector Power Dissipation (Tc = 25°C)	Ta = 25°C	P_C	2.0	W
	Tc = 25°C		25	
Junction Temperature		T_j	150	°C
Storage Temperature Range		T_{stg}	−55~150	°C

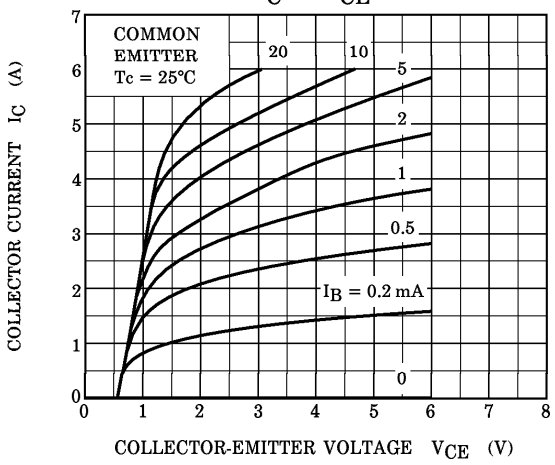
EQUIVALENT CIRCUIT



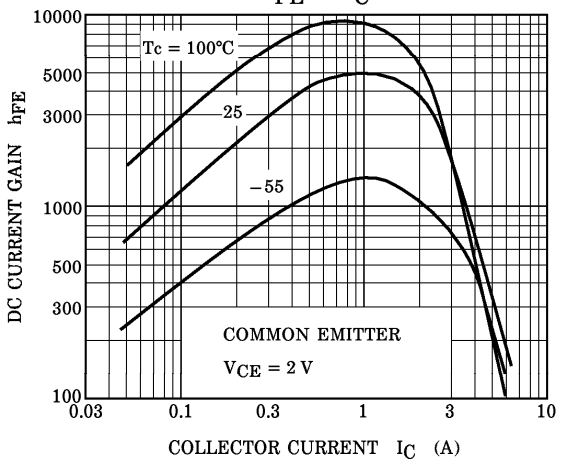
ELECTRICAL CHARACTERISTICS (Tc = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		I_{CBO}	V_{CB} = 300 V, I_E = 0	—	—	0.5	mA
Emitter Cut-off Current		I_{EBO}	V_{EB} = 5 V, I_C = 0	—	—	0.5	mA
Collector-Emitter Breakdown Voltage		$V_{(BR)CEO}$	I_C = 0.5 A, L = 40 mH	250	—	—	V
DC Current Gain		$h_{FE(1)}$	V_{CE} = 2 V, I_C = 2 A	2000	—	—	
		$h_{FE(2)}$	V_{CE} = 2 V, I_C = 4 A	200	—	—	
Collector-Emitter Saturation Voltage		$V_{CE(sat)}$	I_C = 4 A, I_B = 0.04 A	—	—	2.0	V
Base-Emitter Saturation Voltage		$V_{BE(sat)}$	I_C = 4 A, I_B = 0.04 A	—	—	2.5	V
Collector Output Capacitance		C_{ob}	V_{CB} = 50 V, I_E = 0, f = 1 MHz	—	30	—	pF
Switching Time	Turn-on Time	t_{on}		—	1	—	μs
	Storage Time	t_{stg}		—	8	—	
	Fall Time	t_f	$I_{B1} = -I_{B2}$ = 0.04 A, V_{CC} = 100 V DUTY CYCLE ≦ 1%	—	5	—	

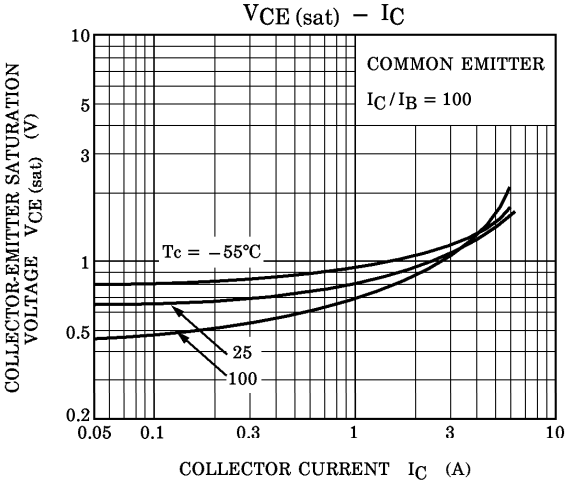
$I_C - V_{CE}$



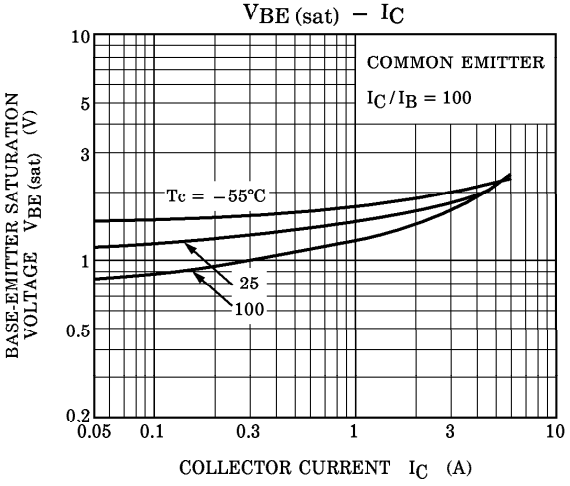
$h_{FE} - I_C$



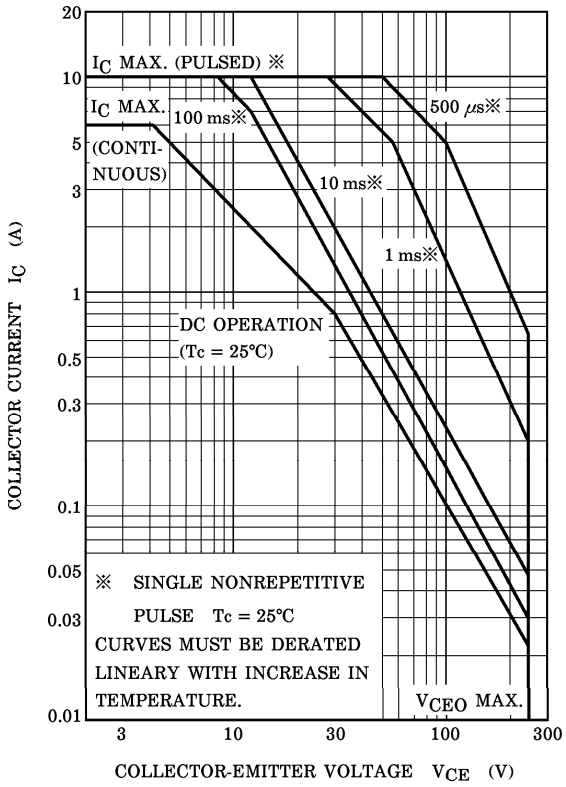
$V_{CE\,(sat)} - I_C$



$V_{BE\,(sat)} - I_C$



SAFE OPERATING AREA



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